



Abstract

We study sketched ridge regression ensembles built from the general class of sketches asymptotically free from the data

- We precisely characterize **asymptotic risk**
- We prove that generalized cross-validation (GCV) provides consistent risk estimation for feature sketching ensembles
- We show that GCV also provides consistent **distribution** estimation enabling prediction intervals
- We employ an **ensemble trick** for efficiently estimating unsketched ridge regression risk

Freely sketched ridge ensembles

Given: data $(\mathbf{X}, \mathbf{y}) \in \mathbb{R}^{n \times p} \times \mathbb{R}$, feature sketches $\mathbf{S}_1, \ldots, \mathbf{S}_K \in \mathbb{R}^{p \times q}$, and the ensemble predictor at regularization level λ

$$\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}} = \frac{1}{K} \sum_{k=1}^{K} \frac{1}{n} \mathbf{S}_{k} \left(\frac{1}{n} \mathbf{S}_{k}^{\top} \mathbf{X}^{\top} \mathbf{X} \mathbf{S}_{k} + \lambda \mathbf{I}_{q} \right)^{-1} \mathbf{S}_{k}^{\top} \mathbf{X}^{\top} \mathbf{S}_{k}^{T} \mathbf{X}^{\top} \mathbf{S}_{k}^{T} \mathbf{X}^{\top} \mathbf{S}_{k}^{T} \mathbf{X}^{\top} \mathbf{S}_{k}^{T} \mathbf{X}^{\top} \mathbf{S}_{k}^{T} \mathbf{X}^{\top} \mathbf{S}_{k}^{T} \mathbf{X}^{\top} \mathbf{X}^{T} \mathbf{X}^{T$$

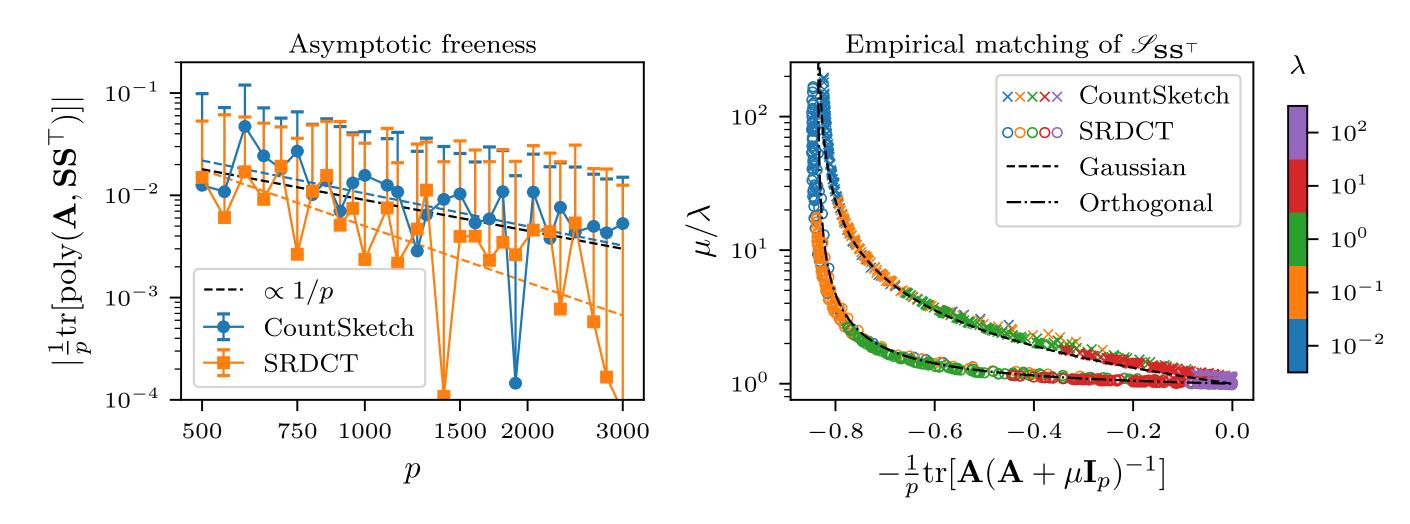
where $\mathbf{S}_k \mathbf{S}_k^{ op}$ is asymptotically free from the data $\frac{1}{n} \mathbf{X}^{ op} \mathbf{X}$ Two matrices A and B are almost surely asymptotically free if all mixed alternating products of centered polynomials are also centered:

$$\overline{\mathrm{tr}}[p_1(\mathbf{A})p_2(\mathbf{B})\dots p_{L-1}(\mathbf{A})p_L(\mathbf{B})] \xrightarrow{\mathrm{a.s.}} 0.$$

Examples of known asymptotically free sketches:

- Independent: $[\mathbf{S}_k]_{ij} \stackrel{\text{i.i.d.}}{\sim} \mathcal{D}$, zero mean, bounded moments
- Rotationally invariant: $\mathbf{S}_k = \mathbf{U}_k \mathbf{Q}_k$ with \mathbf{U}_k Haar-distributed
- Randomized Fourier transform: $\mathbf{S}_k = \mathbf{D}_k \Phi_{DFT} \mathbf{\widehat{S}}_k$

We provide **empirical support** for freeness for practical sketches.



Asymptotically free sketched ridge ensembles: Risks, cross-validation, and tuning

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Generalized cross-validation (GCV)

Goal: estimate the joint distribution of true labels and predictions $(y_0, x_0^{\top} \widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}})$ in order to estimate risk $T(\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}}) = \mathbb{E}\left[t(y_0, x_0^{\top} \widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}})\right].$

Ensemble predictions are linear smoothers $\mathbf{X}\widehat{\boldsymbol{\beta}}_{\lambda}^{\mathrm{ens}} = \mathbf{L}_{\lambda}^{\mathrm{ens}}\mathbf{y}$ for

$$\mathbf{L}_{\lambda}^{\text{ens}} = \frac{1}{K} \sum_{k=1}^{K} \mathbf{L}_{\lambda}^{k} = \frac{1}{n} \mathbf{X} \mathbf{S}_{k} (\frac{1}{n} \mathbf{S}_{k}^{\top} \mathbf{X}^{\top} \mathbf{X} \mathbf{S}_{k} + \lambda \mathbf{I}_{q})^{-1} \mathbf{S}_{k}^{\top} \mathbf{X}^{\top},$$

giving us the GCV-corrected empirical distribution

$$\widehat{P}_{\lambda}^{\text{ens}} = \frac{1}{n} \sum_{i=1}^{n} \delta \left\{ \left(y_i, \frac{x_i^{\top} \widehat{\beta}_{\lambda}^{\text{ens}}}{1 - 1} \right) \right\}$$

We plug in $\widehat{P}_{\lambda}^{\text{ens}}$ to obtain **risk estimators** $\widehat{T}(\widehat{\boldsymbol{eta}}_{\lambda}^{\mathrm{ens}}) = \int t(y,z) d\widehat{P}_{\lambda}^{\mathrm{ens}}(y,z) \quad \text{and} \quad \widehat{R}$

Sketched ensemble risk

Free sketches satisfy an **asymptotic equivalence**: $\mathbf{S} (\mathbf{S}^{ op} \mathbf{A} \mathbf{S} + \lambda \mathbf{I}_q)^{-1} \mathbf{S}^{ op} \simeq (\mathbf{A} + \mu \mathbf{I}_p)^{-1}$ where $\mu \simeq \lambda \mathscr{S}_{\mathbf{SS}^{\top}} \left(-\frac{1}{p} \operatorname{tr} \left[\mathbf{S}^{\top} \mathbf{AS} \left(\mathbf{S}^{\top} \mathbf{AS} + \lambda \mathbf{I}_{q} \right)^{-1} \right] \right).$

Theoretical results

Theorem 1. For any free sketches S_k , $R(\widehat{oldsymbol{eta}}_{\lambda}^{ ext{ens}}) \simeq R(\widehat{oldsymbol{eta}}_{\mu}^{ ext{ridge}}) + rac{\mu'\Delta}{K} \quad ext{and} \quad \widehat{R}$ where $\widehat{oldsymbol{eta}}_{\mu}^{ ext{ridge}} = \left(rac{1}{n} \mathbf{X}^{ op} \mathbf{X} + \mu \mathbf{I}_p
ight)^{-1} rac{1}{n} \mathbf{X}^{ op} \mathbf{Y}.$ **Theorem 2.** Under random data assumptions on X and y, $\mu' \simeq \mu''$, and therefore $\widehat{R}(\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}}) \simeq R(\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}})$. **Theorem 3.** For any t pseudo-Lipshitz of order 2, $\widehat{T}(\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}}) \simeq T(\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}}), \text{ and there}$

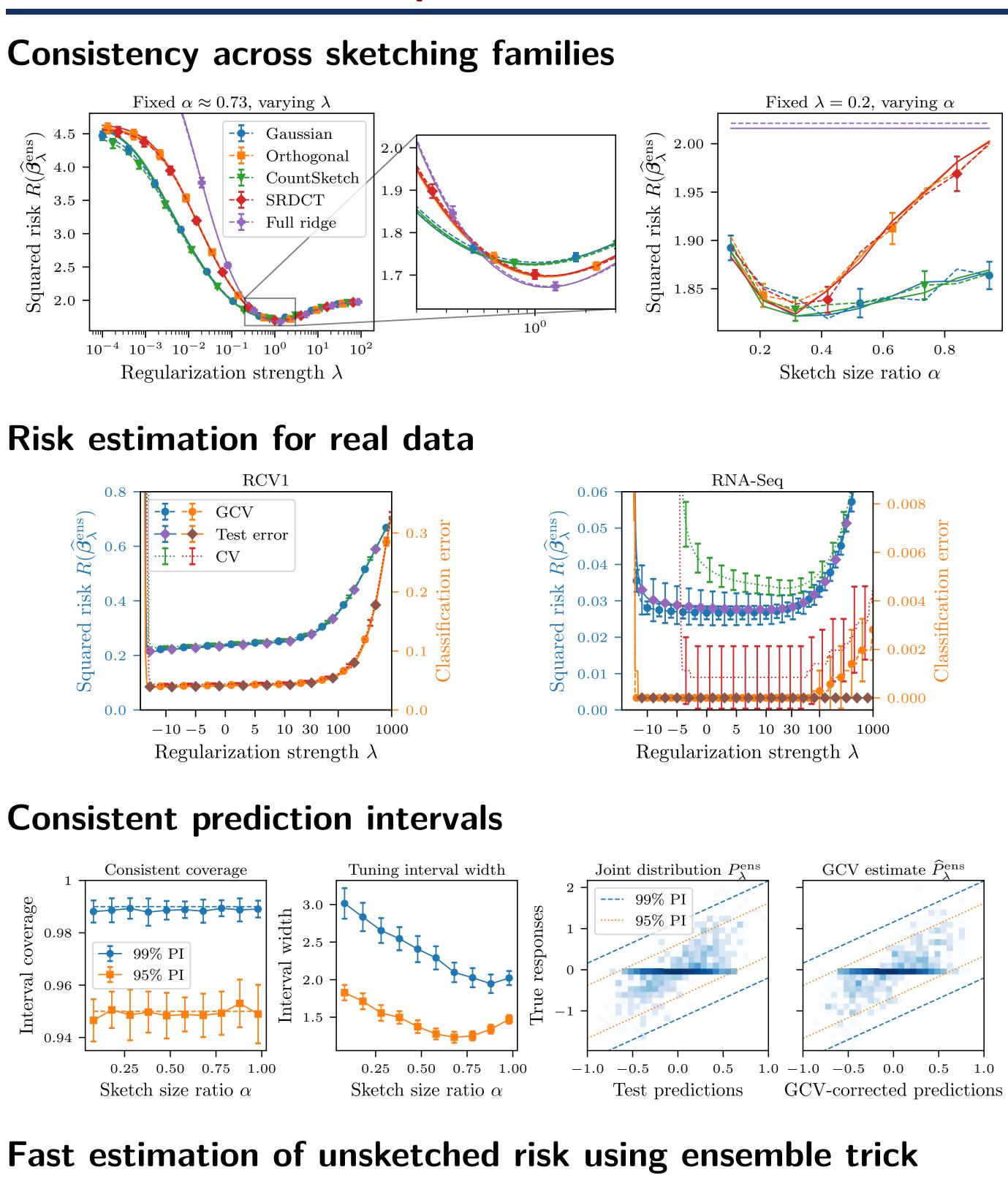
 $\mathbf{X}^{\top}\mathbf{y}$

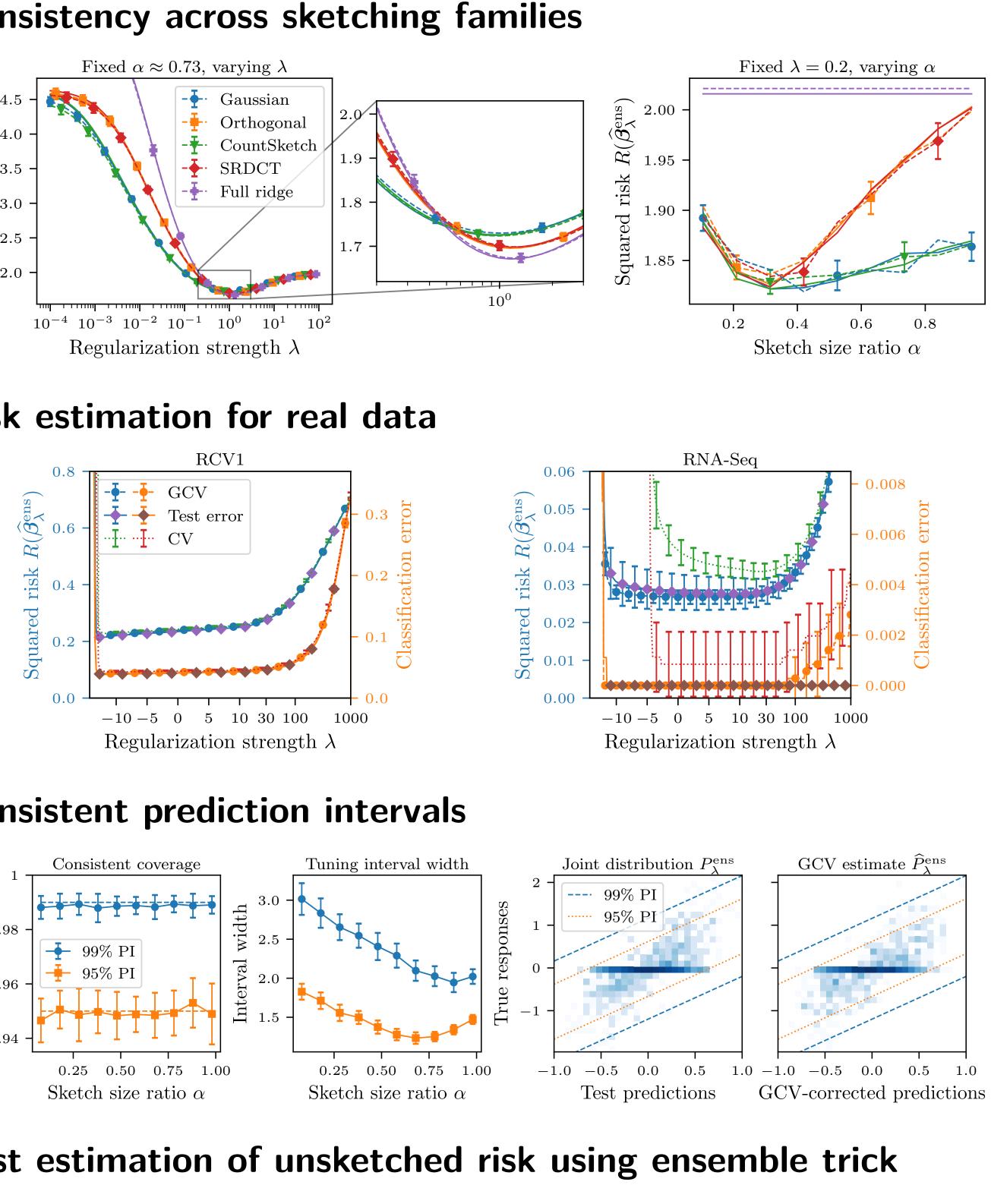
 $\frac{1}{2}$ tr [L^{ens}]

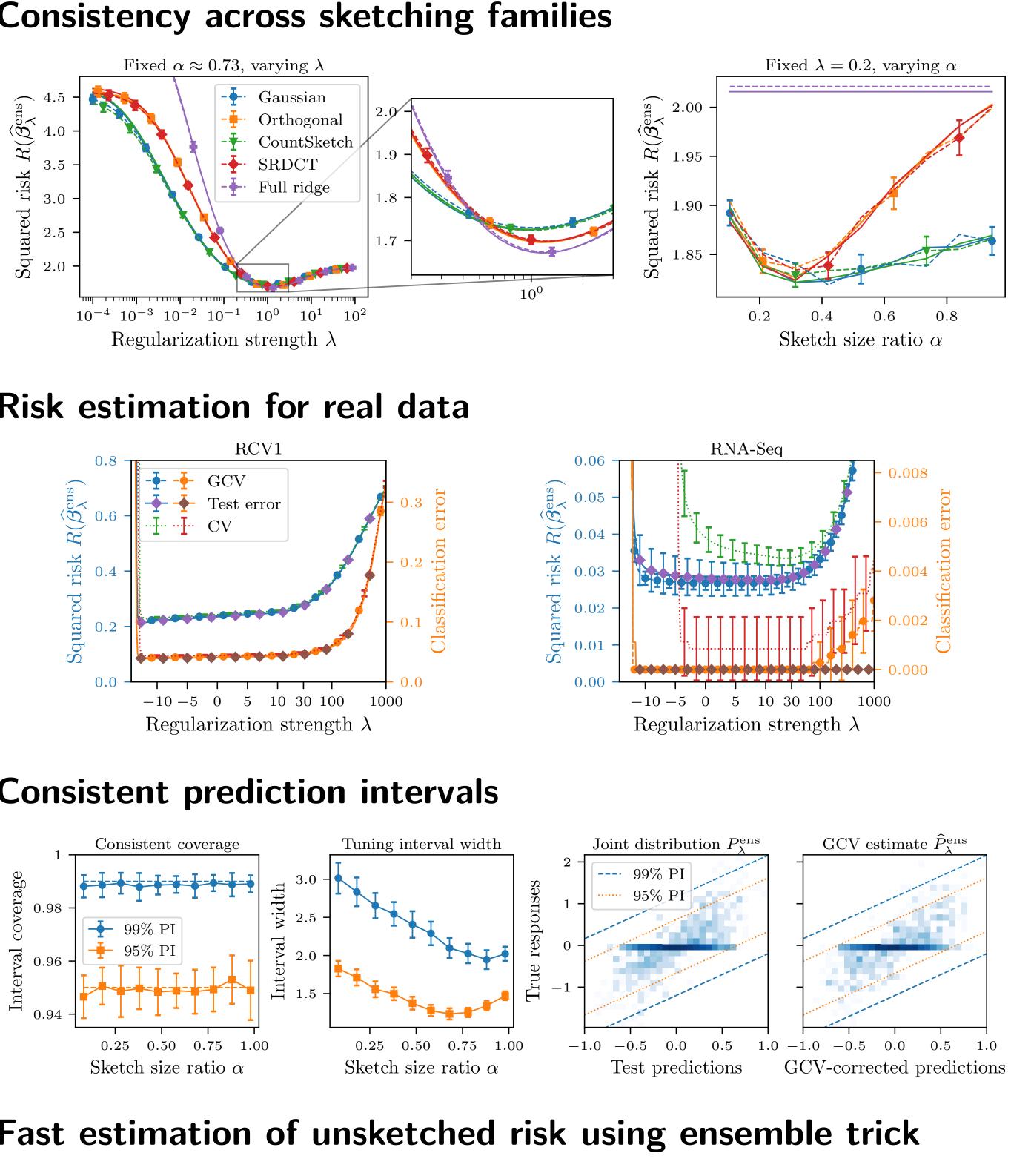
$$\widehat{R}(\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}}) = \int (y - z)^2 d\widehat{P}_{\lambda}^{\text{ens}}(y, z)$$

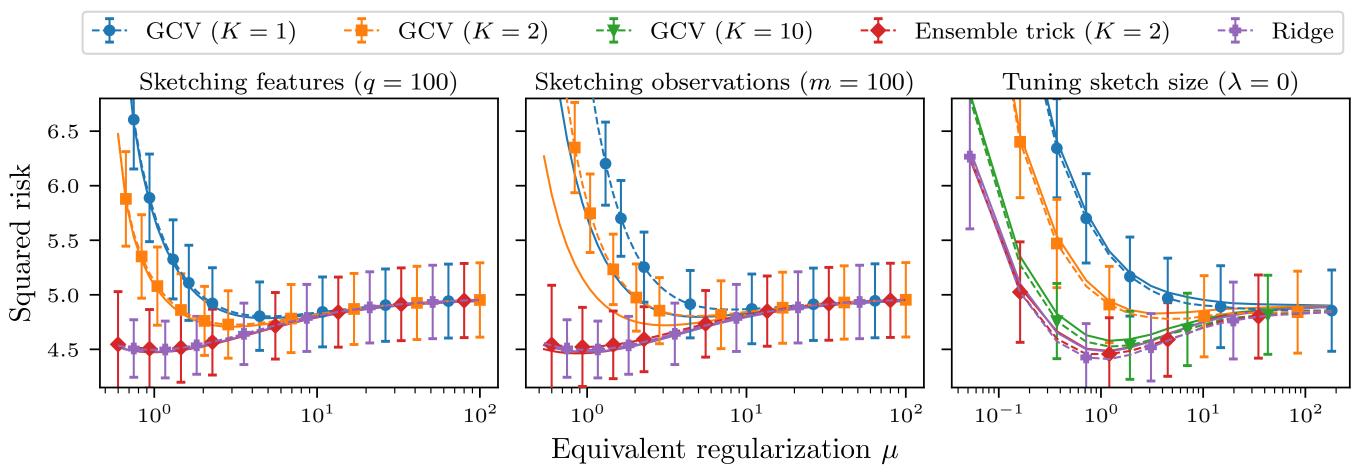
$$\widehat{R}(\widehat{\boldsymbol{\beta}}_{\lambda}^{\text{ens}}) \simeq \widehat{R}(\widehat{\boldsymbol{\beta}}_{\mu}^{\text{ridge}}) + \frac{\mu''\Delta}{K},$$

efore
$$\widehat{P}_{\lambda}^{\text{ens}} \stackrel{2}{\Rightarrow} P_{\lambda}^{\text{ens}}$$
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Empirical results

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